

## RF Power LDMOS Transistors

### High Ruggedness N-Channel Enhancement-Mode Lateral MOSFETs

These RF power devices are designed for pulse applications operating at frequencies from 900 to 1215 MHz. The devices are suitable for use in pulse applications with large duty cycles and long pulses and are ideal for use in high power military and commercial L-Band radar applications such as IFF and DME/TACAN.

**Typical Short Pulse Performance:** In 900–1215 MHz reference circuit,  
 $V_{DD} = 52$  Vdc,  $I_{DQ(A+B)} = 100$  mA

| Frequency (MHz) | Signal Type                           | $P_{out}$ (W) | $G_{ps}$ (dB) | $\eta_D$ (%) |
|-----------------|---------------------------------------|---------------|---------------|--------------|
| 900             | Pulse (128 $\mu$ sec, 10% Duty Cycle) | 1615 Peak     | 15.2          | 54.0         |
| 960             |                                       | 1560 Peak     | 17.3          | 55.7         |
| 1030            |                                       | 1500 Peak     | 17.8          | 53.8         |
| 1090            |                                       | 1530 Peak     | 18.0          | 54.5         |
| 1215            |                                       | 1200 Peak     | 19.2          | 58.5         |

#### Load Mismatch/Ruggedness

| Frequency (MHz) | Signal Type                           | VSWR                       | $P_{in}$ (W)               | Test Voltage | Result                |
|-----------------|---------------------------------------|----------------------------|----------------------------|--------------|-----------------------|
| 1030 (1)        | Pulse (128 $\mu$ sec, 10% Duty Cycle) | > 20:1 at all Phase Angles | 20.2 Peak (3 dB Overdrive) | 52           | No Device Degradation |

1. Measured in 1030 MHz narrowband reference circuit.

#### Features

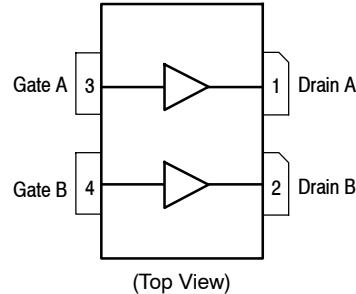
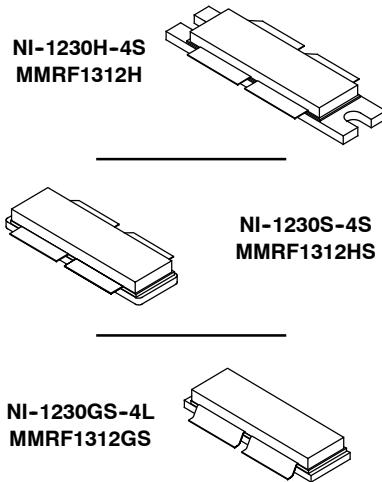
- Internally input and output matched for broadband operation and ease of use
- Device can be used in a single-ended, push-pull or quadrature configuration
- Qualified up to a maximum of 52 V<sub>DD</sub> operation
- High ruggedness, handles > 20:1 VSWR
- Integrated ESD protection with greater negative voltage range for improved Class C operation and gate voltage pulsing
- Characterized with series equivalent large-signal impedance parameters

#### Typical Applications

- Air traffic control systems (ATC), including ground-based secondary radars such as IFF interrogators or transponders
- Distance measuring equipment (DME)
- Tactical air navigation (TACAN)

**MMRF1312H  
MMRF1312HS  
MMRF1312GS**

**900–1215 MHz, 1000 W PEAK, 52 V  
AIRFAST RF POWER LDMOS  
TRANSISTORS**



Note: The backside of the package is the source terminal for the transistor.

**Figure 1. Pin Connections**

**Table 1. Maximum Ratings**

| Rating  | Symbol           | Value        | Unit      |
|---|------------------|--------------|-----------|
| Drain-Source Voltage  | V <sub>DSS</sub> | -0.5, +112   | Vdc       |
| Gate-Source Voltage   | V <sub>GS</sub>  | -6.0, +10    | Vdc       |
| Storage Temperature Range   | T <sub>stg</sub> | -65 to +150  | °C        |
| Case Operating Temperature Range                                      | T <sub>C</sub>   | -40 to 150   | °C        |
| Operating Junction Temperature Range (1)                              | T <sub>J</sub>   | -40 to 225   | °C        |
| Total Device Dissipation @ T <sub>C</sub> = 25°C<br>Derate above 25°C | P <sub>D</sub>   | 1053<br>5.26 | W<br>W/°C |

**Table 2. Thermal Characteristics**

| Characteristic  | Symbol           | Value (2) | Unit |
|---|------------------|-----------|------|
| Thermal Impedance, Junction to Case<br>Pulse: Case Temperature 64°C, 1000 W Peak, 128 μsec Pulse Width,<br>10% Duty Cycle, 50 Vdc, I <sub>DQ</sub> = 100 mA, 1030 MHz | Z <sub>θJC</sub> | 0.017     | °C/W |

**Table 3. ESD Protection Characteristics**

| Test Methodology                      | Class             |
|---------------------------------------|-------------------|
| Human Body Model (per JESD22-A114)    | 2, passes 2500 V  |
| Machine Model (per EIA/JESD22-A115)   | B, passes 250 V   |
| Charge Device Model (per JESD22-C101) | IV, passes 2000 V |

**Table 4. Electrical Characteristics** (T<sub>A</sub> = 25°C unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

**Off Characteristics (3)**

|   |                      |     |   |    |      |
|---|----------------------|-----|---|----|------|
| Gate-Source Leakage Current<br>(V <sub>GS</sub> = 5 Vdc, V <sub>DS</sub> = 0 Vdc)               | I <sub>GSS</sub>     | —   | — | 1  | μAdc |
| Drain-Source Breakdown Voltage<br>(V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 10 μA)             | V <sub>(BR)DSS</sub> | 112 | — | —  | Vdc  |
| Zero Gate Voltage Drain Leakage Current<br>(V <sub>DS</sub> = 50 Vdc, V <sub>GS</sub> = 0 Vdc)  | I <sub>DSS</sub>     | —   | — | 1  | μAdc |
| Zero Gate Voltage Drain Leakage Current<br>(V <sub>DS</sub> = 112 Vdc, V <sub>GS</sub> = 0 Vdc) | I <sub>DSS</sub>     | —   | — | 10 | μAdc |

**On Characteristics**

|  |                     |      |      |      |     |
|--|---------------------|------|------|------|-----|
| Gate Threshold Voltage (3)<br>(V <sub>DS</sub> = 10 Vdc, I <sub>D</sub> = 520 μAdc)                              | V <sub>GS(th)</sub> | 1.3  | 1.8  | 2.3  | Vdc |
| Gate Quiescent Voltage (4)<br>(V <sub>DD</sub> = 50 Vdc, I <sub>D</sub> = 100 mAdc, Measured in Functional Test) | V <sub>GS(Q)</sub>  | 1.5  | 2.0  | 2.5  | Vdc |
| Drain-Source On-Voltage (3)<br>(V <sub>GS</sub> = 10 Vdc, I <sub>D</sub> = 2.6 Adc)                              | V <sub>DS(on)</sub> | 0.05 | 0.17 | 0.35 | Vdc |

**Dynamic Characteristics (3)**

|  |                  |   |     |   |    |
|--|------------------|---|-----|---|----|
| Reverse Transfer Capacitance<br>(V <sub>DS</sub> = 50 Vdc ± 30 mV(rms)ac @ 1 MHz, V <sub>GS</sub> = 0 Vdc) | C <sub>rss</sub> | — | 2.5 | — | pF |
|--|------------------|---|-----|---|----|

1. Continuous use at maximum temperature will affect MTTF.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.nxp.com/RF> and search for AN1955.
3. Each side of device measured separately.
4. Measurement made with device in push-pull configuration.

(continued)

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) **(continued)**

| Characteristic   | Symbol   | Min  | Typ  | Max  | Unit |
|--|----------|------|------|------|------|
| <b>Functional Tests (1,2)</b> (In Freescale Narrowband Production Test Fixture, 50 ohm system) $V_{DD} = 50 \text{ Vdc}$ , $I_{DQ(A+B)} = 100 \text{ mA}$ , $P_{out} = 1000 \text{ W}$ Peak (100 W Avg.), $f = 1030 \text{ MHz}$ , 128 $\mu\text{sec}$ Pulse Width, 10% Duty Cycle |          |      |      |      |      |
| Power Gain   | $G_{ps}$ | 18.5 | 19.6 | 22.0 | dB   |
| Drain Efficiency   | $\eta_D$ | 55.5 | 59.7 | —    | %    |
| Input Return Loss  | IRL      | —    | -15  | -9   | dB   |

**Table 5. Load Mismatch/Ruggedness** (In Freescale Narrowband Production Test Fixture, 50 ohm system)  $I_{DQ(A+B)} = 100 \text{ mA}$ 

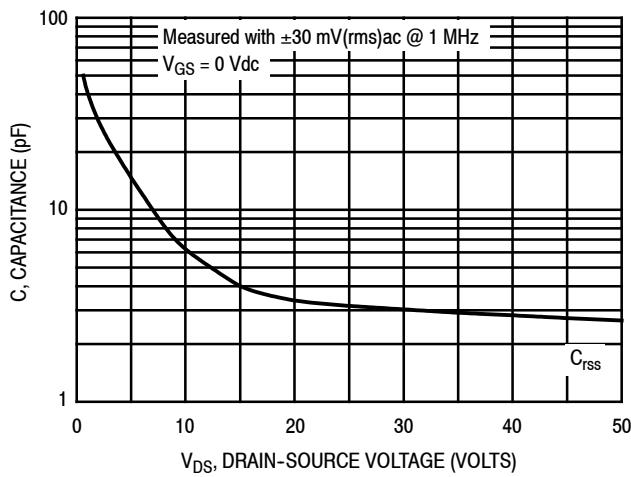
| Frequency<br>(MHz) | Signal Type  | VSWR                          | $P_{in}$<br>(W)               | Test Voltage, $V_{DD}$ | Result                   |
|--------------------|--|-------------------------------|-------------------------------|------------------------|--------------------------|
| 1030               | Pulse<br>(128 $\mu\text{sec}$ ,<br>10% Duty Cycle) | > 20:1 at all<br>Phase Angles | 20.2 Peak<br>(3 dB Overdrive) | 52                     | No Device<br>Degradation |

**Table 6. Ordering Information**

| Device       | Tape and Reel Information                            | Package                 |
|--------------|--|-------------------------|
| MMRF1312HR5  |  | NI-1230H-4S, Eared      |
| MMRF1312HSR5 | R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel | NI-1230S-4S, Earless    |
| MMRF1312GSR5 |  | NI-1230GS-4L, Gull Wing |

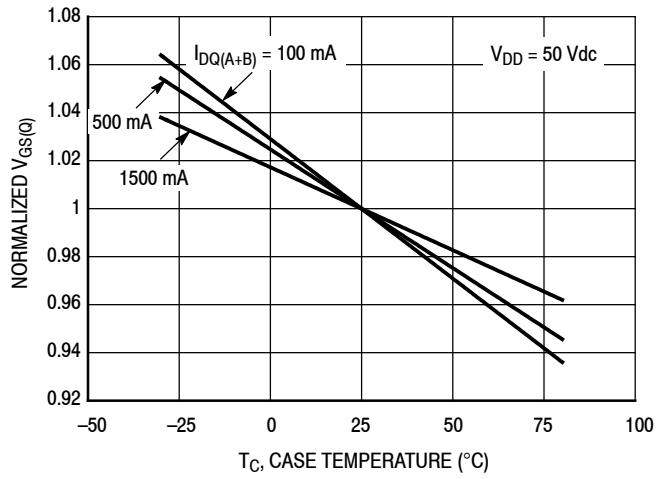
1. Measurement made with device in push-pull configuration.
2. Measurements made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GS) parts.

## TYPICAL CHARACTERISTICS



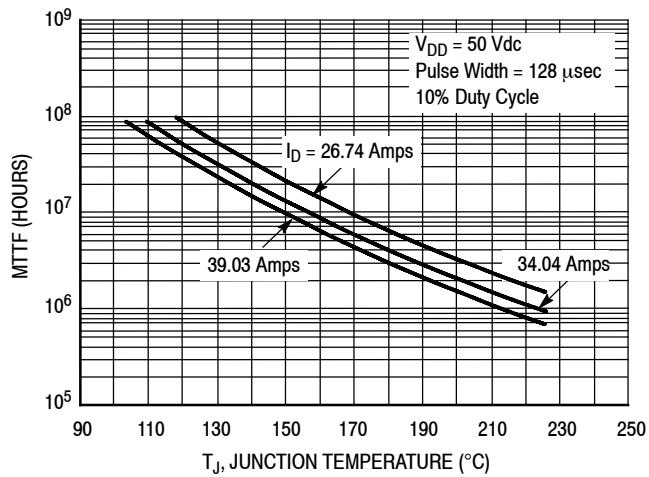
**Note:** Each side of device measured separately.

**Figure 2. Capacitance versus Drain-Source Voltage**



| $I_{DQ} (\text{mA})$ | Slope ( $\text{mV}/^\circ\text{C}$ ) |
|----------------------|--------------------------------------|
| 100                  | -2.36                                |
| 500                  | -2.26                                |
| 1500                 | -1.84                                |

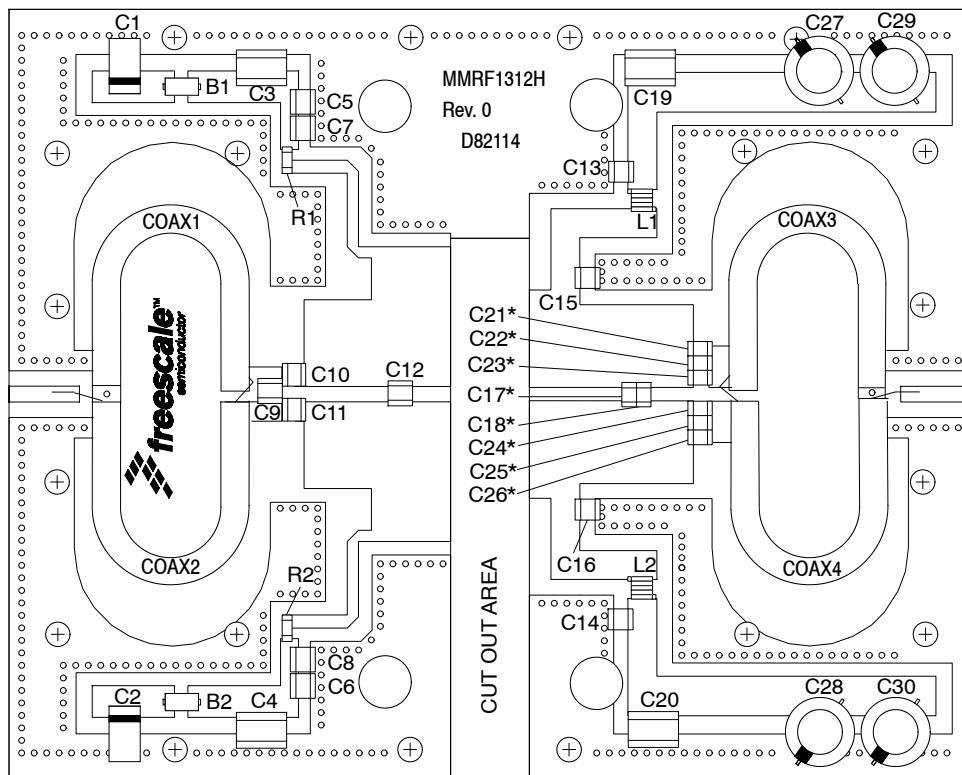
**Figure 3. Normalized  $V_{GS}$  versus Quiescent Current and Case Temperature**



**Note:** MTTF value represents the total cumulative operating time under indicated test conditions.

**Figure 4. MTTF versus Junction Temperature — Pulse**

## 1030 MHz NARROWBAND PRODUCTION TEST FIXTURE — 4.0" x 5.0" (10.2 cm x 12.7 cm)



\* C17, C18, C21, C22, C23, C24, C25 and C26 are mounted vertically.

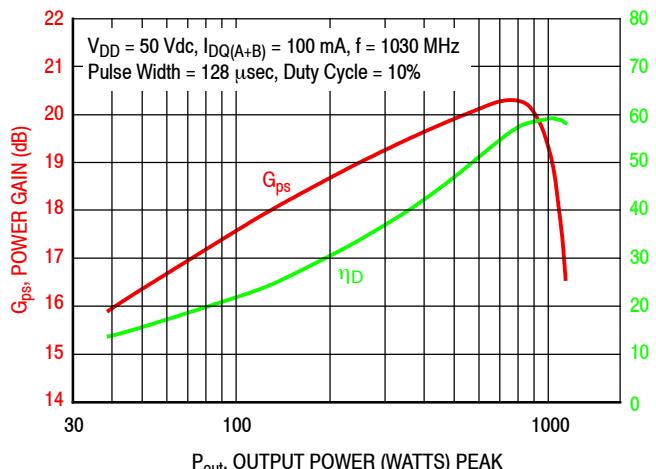
**Figure 5. MMRF1312H(HS) Narrowband Test Circuit Component Layout — 1030 MHz**

**Table 7. MMRF1312H(HS) Narrowband Test Circuit Component Designations and Values — 1030 MHz**

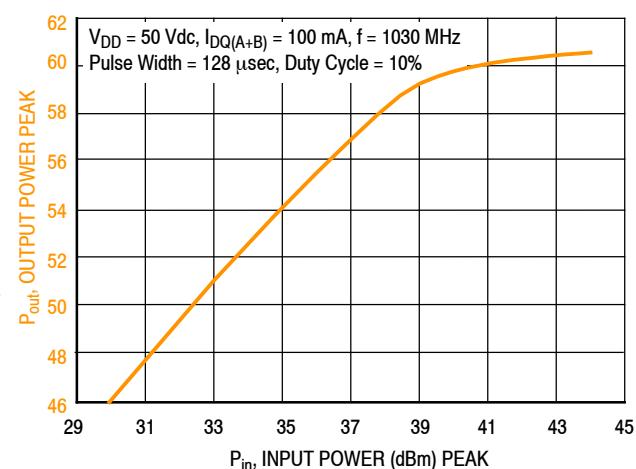
| Part                         | Description                               | Part Number          | Manufacturer  |
|------------------------------|---|----------------------|---------------|
| B1, B2                       | Short RF Bead                             | 2743019447           | Fair-Rite     |
| C1, C2                       | 22 $\mu$ F, 35 V Tantalum Capacitors      | T491X226K035AT       | Kemet         |
| C3, C4                       | 2.2 $\mu$ F Chip Capacitors               | C1825C225J5RACTU     | Kemet         |
| C5, C6                       | 0.1 $\mu$ F Chip Capacitors               | CDR33BX104AKWS       | AVX           |
| C7, C8                       | 36 pF Chip Capacitors                     | ATC100B360JT500XT    | ATC           |
| C9                           | 2.7 pF Chip Capacitor                     | ATC100B2R7CT500XT    | ATC           |
| C10, C11                     | 30 pF Chip Capacitors                     | ATC100B300JT500XT    | ATC           |
| C12                          | 8.2 pF Chip Capacitor                     | ATC100B8R2CT500XT    | ATC           |
| C13, C14                     | 36 pF Chip Capacitors                     | ATC100B360JT500XT    | ATC           |
| C15, C16                     | 7.5 pF Chip Capacitors                    | ATC100B7R5CT500XT    | ATC           |
| C17                          | 4.7 pF Chip Capacitor                     | ATC100B4R7CT500XT    | ATC           |
| C18                          | 4.3 pF Chip Capacitor                     | ATC100B4R3CT500XT    | ATC           |
| C19, C20                     | 0.01 $\mu$ F Chip Capacitors              | C1825C103K1GACTU     | Kemet         |
| C21, C22, C23, C24, C25, C26 | 43 pF Chip Capacitors                     | ATC100B430JT500XT    | ATC           |
| C27, C28, C29, C30           | 470 $\mu$ F, 63 V Electrolytic Capacitors | MCGPR63V477M13X26-RH | Multicomp     |
| Coax1, Coax2, Coax3, Coax4   | 35 $\Omega$ Flex Cable 1.98"              | HSF-141C-35          | Hongsen Cable |
| L1, L2                       | 12 nH, 3 Turn Inductors                   | GA3094-ALC           | Coilcraft     |
| R1, R2                       | 1.1 k $\Omega$ , 1/4 W Chip Resistors     | CRCW12061K10FKEA     | Vishay        |
| PCB                          | Arlon, AD255A, 0.03", $\epsilon_r = 2.55$ | D82114               | MTL           |

## MMRF1312H MMRF1312HS MMRF1312GS

## TYPICAL CHARACTERISTICS — 1030 MHz NARROWBAND PRODUCTION TEST FIXTURE

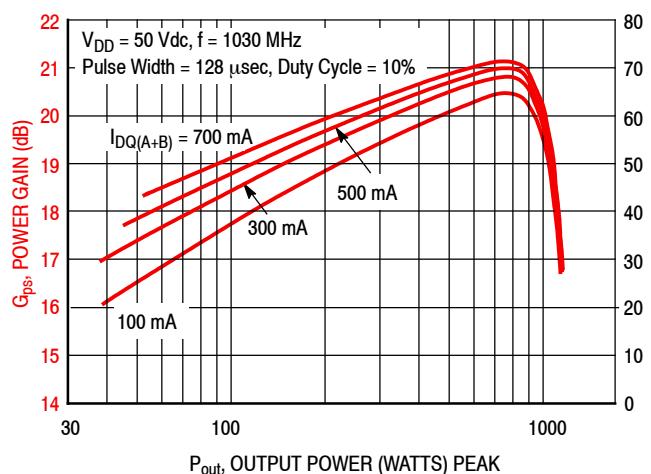


**Figure 6. Power Gain and Drain Efficiency versus Output Power**

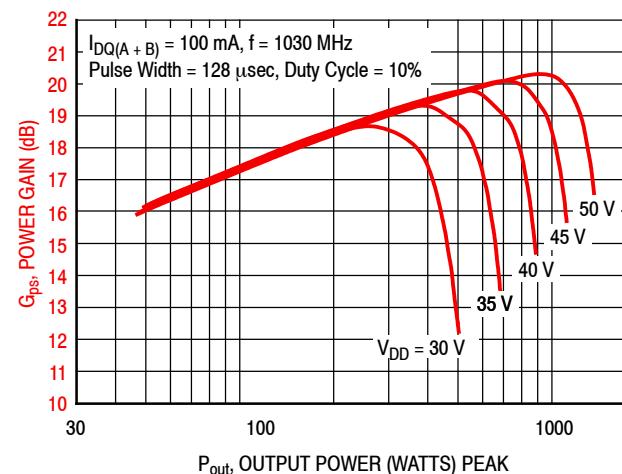


| $f$<br>(MHz) | $P_{1dB}$<br>(W) | $P_{3dB}$<br>(W) |
|--------------|------------------|------------------|
| 1030         | 1002             | 1115             |

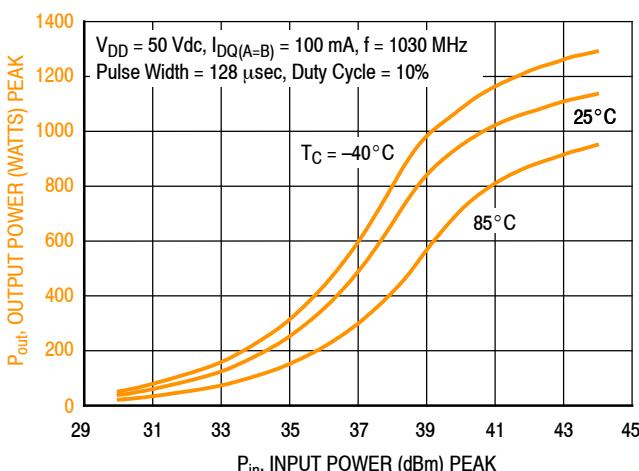
**Figure 7. Output Power versus Input Power**



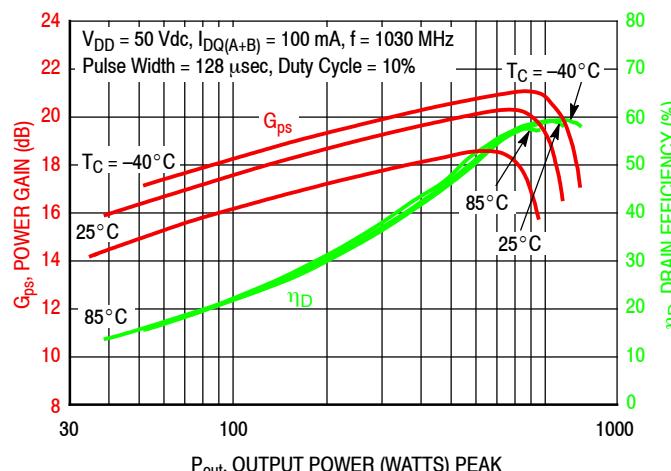
**Figure 8. Power Gain versus Output Power**



**Figure 9. Power Gain versus Output Power**



**Figure 10. Output Power versus Input Power**



**Figure 11. Power Gain and Drain Efficiency versus Output Power**

## 1030 MHz NARROWBAND PRODUCTION TEST FIXTURE

| f<br>MHz | Z <sub>source</sub><br>Ω | Z <sub>load</sub><br>Ω |
|----------|--------------------------|------------------------|
| 1030     | 2.40 - j3.73             | 1.9 + j1.00            |

Z<sub>source</sub> = Test circuit impedance as measured from gate to gate, balanced configuration.

Z<sub>load</sub> = Test circuit impedance as measured from drain to drain, balanced configuration.

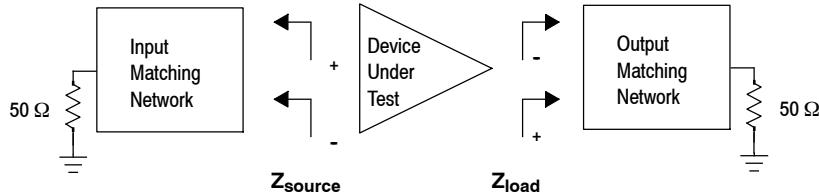
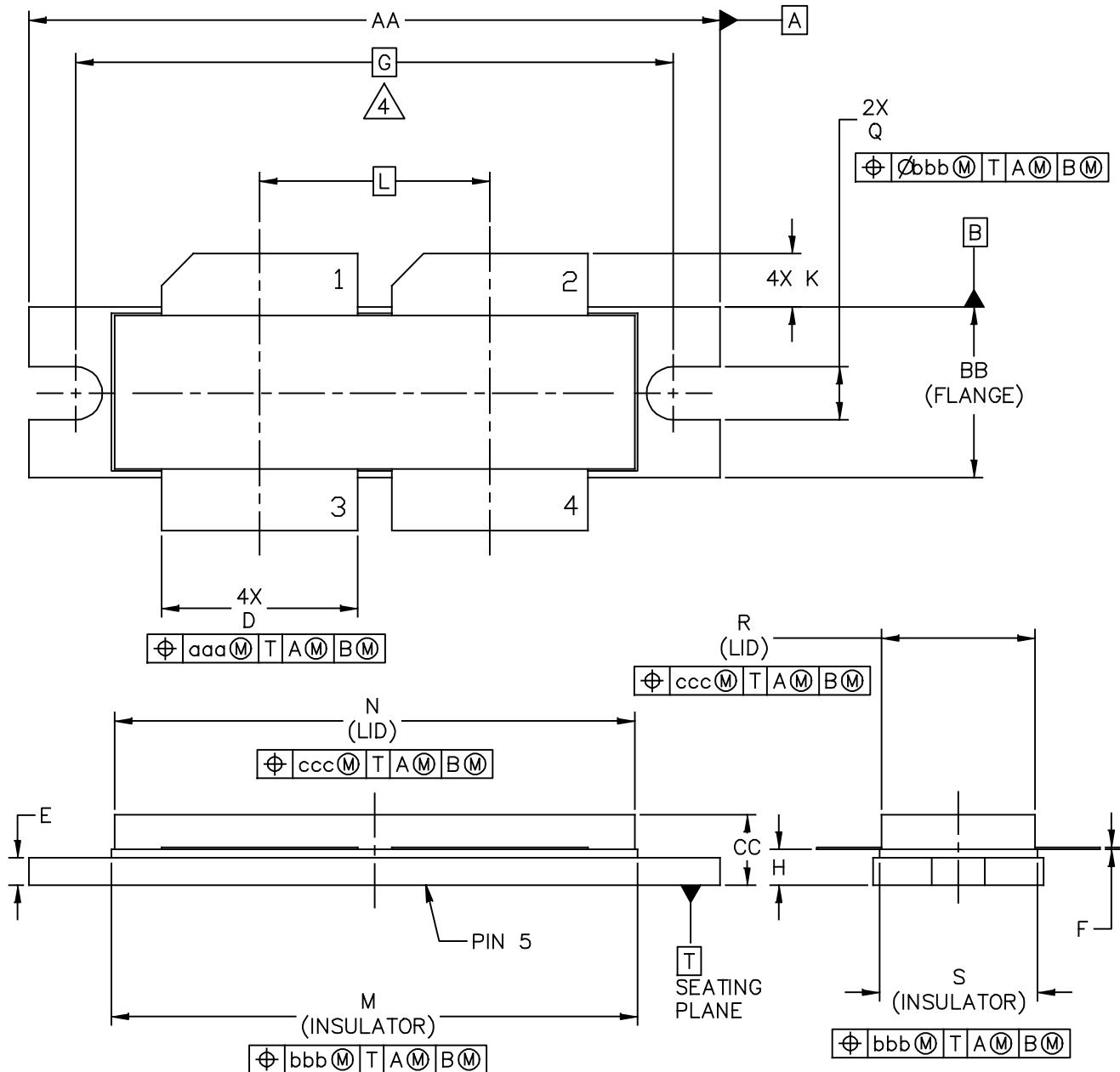


Figure 12. Narrowband Series Equivalent Source and Load Impedance — 1030 MHz

## PACKAGE DIMENSIONS



| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED. | MECHANICAL OUTLINE       | PRINT VERSION NOT TO SCALE |
|---|--------------------------|----------------------------|
| TITLE:<br><br>NI-1230-4H                                | DOCUMENT NO: 98ASB16977C | REV: F                     |
| STANDARD: NON-JEDEC                                     |                          |                            |
| 28 FEB 2013   |                          |                            |

**MMRF1312H MMRF1312HS MMRF1312GS**

RF Device Data  
Freescale Semiconductor, Inc.

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY.



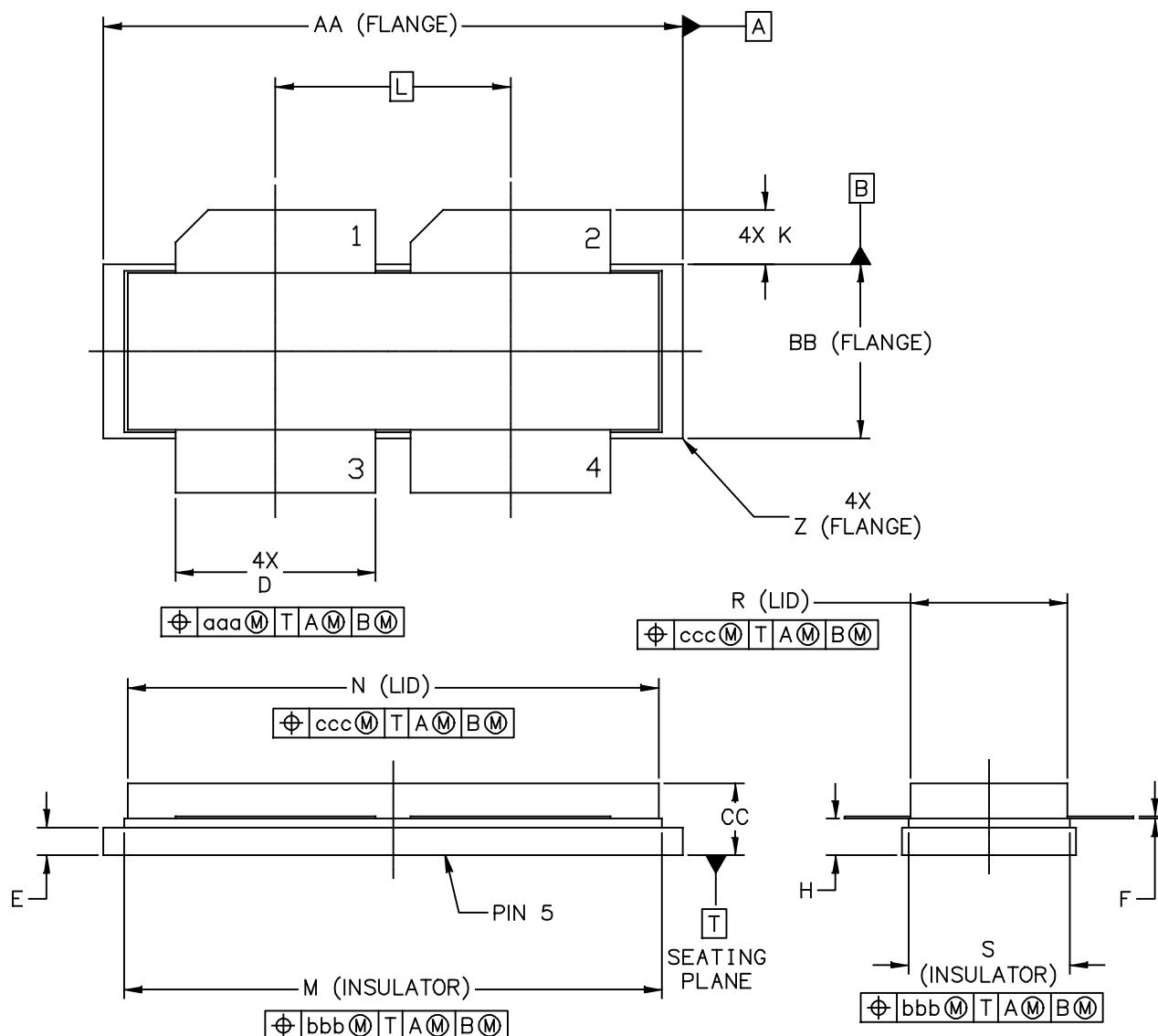
4. RECOMMENDED BOLT CENTER DIMENSION OF 1.52 INCH (38.61 MM) BASED ON M3 SCREW.

| DIM | INCH  |       | MILLIMETER |       | DIM | INCH  |       | MILLIMETER |       |
|-----|-------|-------|------------|-------|-----|-------|-------|------------|-------|
|     | MIN   | MAX   | MIN        | MAX   |     | MIN   | MAX   | MIN        | MAX   |
| AA  | 1.615 | 1.625 | 41.02      | 41.28 | N   | 1.218 | 1.242 | 30.94      | 31.55 |
| BB  | .395  | .405  | 10.03      | 10.29 | Q   | .120  | .130  | 3.05       | 3.30  |
| CC  | .170  | .190  | 4.32       | 4.83  | R   | .355  | .365  | 9.02       | 9.27  |
| D   | .455  | .465  | 11.56      | 11.81 | S   | .365  | .375  | 9.27       | 9.53  |
| E   | .062  | .066  | 1.57       | 1.68  |     |       |       |            |       |
| F   | .004  | .007  | 0.10       | 0.18  |     |       |       |            |       |
| G   | 1.400 | BSC   | 35.56      | BSC   | aaa |       | .013  |            | 0.33  |
| H   | .082  | .090  | 2.08       | 2.29  | bbb |       | .010  |            | 0.25  |
| K   | .117  | .137  | 2.97       | 3.48  | ccc |       | .020  |            | 0.51  |
| L   | .540  | BSC   | 13.72      | BSC   |     |       |       |            |       |
| M   | 1.219 | 1.241 | 30.96      | 31.52 |     |       |       |            |       |

|   |                          |                            |
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| TITLE:<br><br>NI-1230-4H                                | DOCUMENT NO: 98ASB16977C | REV: F                     |
|   | STANDARD: NON-JEDEC      |                            |
|   |                          | 28 FEB 2013                |

**MMRF1312H MMRF1312HS MMRF1312GS**



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|---|--|----------------------------|
| TITLE:<br><br>NI-1230-4S                          | DOCUMENT NO: 98ARB18247C<br><br>STANDARD: NON-JEDEC<br><br>SOT1829-1 | REV: H<br><br>19 FEB 2016  |

**MMRF1312H MMRF1312HS MMRF1312GS**

RF Device Data  
Freescale Semiconductor, Inc.

NOTES:

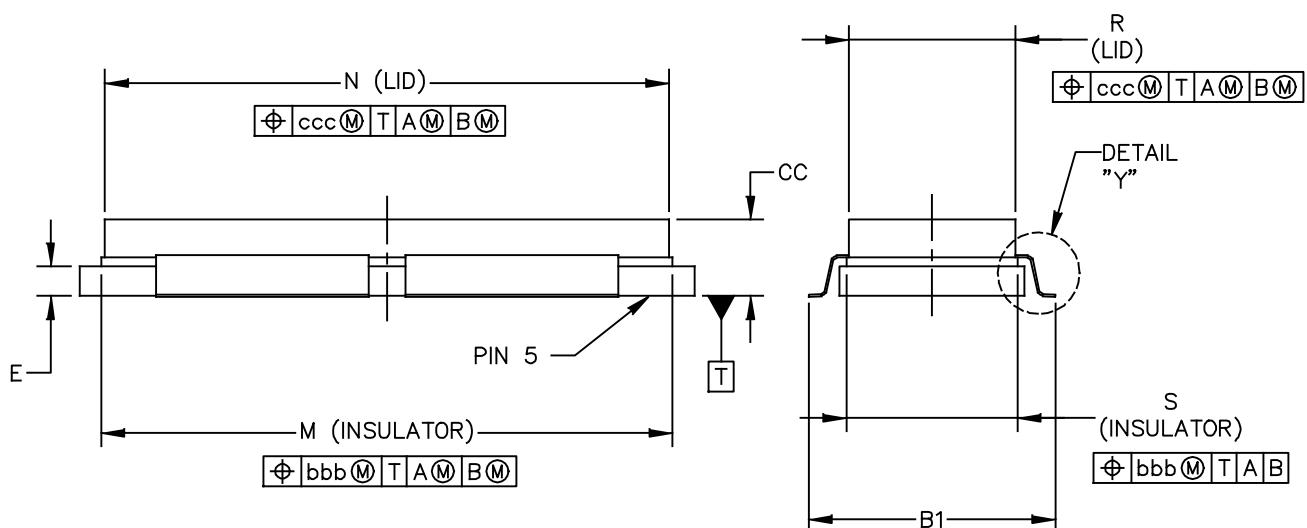
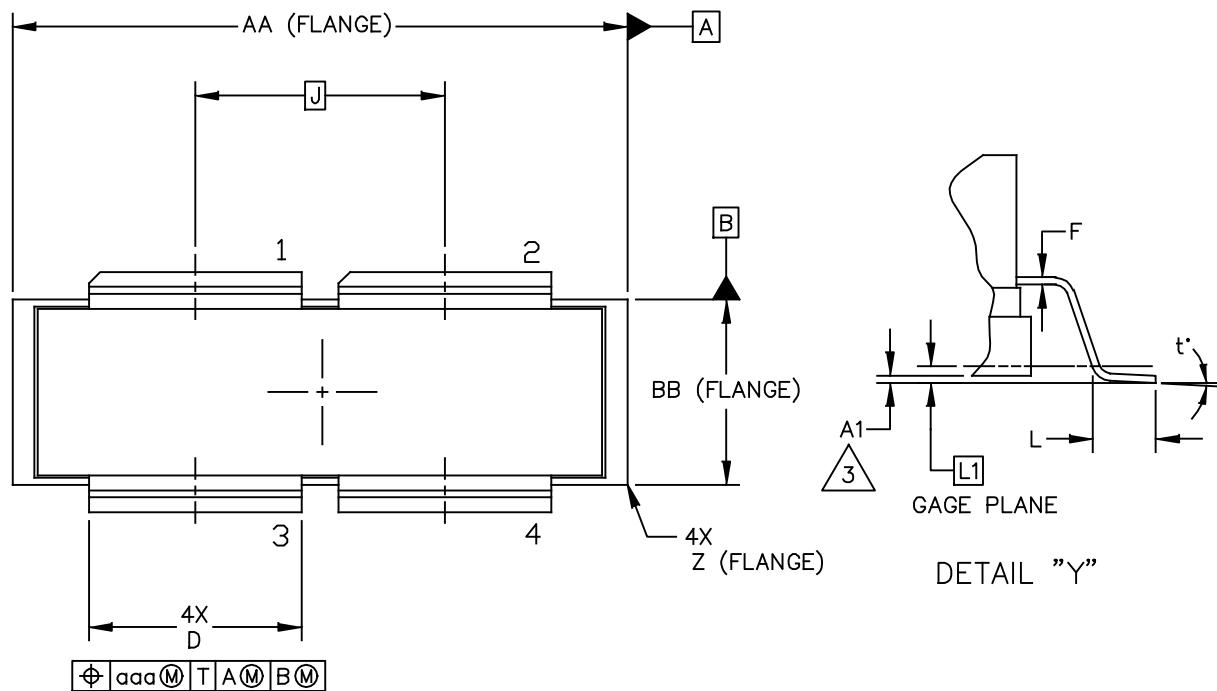
1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY

| DIM | INCHES   |       | MILLIMETERS |       | DIM | INCHES |       | MILLIMETERS |       |
|-----|----------|-------|-------------|-------|-----|--------|-------|-------------|-------|
|     | MIN      | MAX   | MIN         | MAX   |     | MIN    | MAX   | MIN         | MAX   |
| AA  | 1.265    | 1.275 | 32.13       | 32.39 | R   | .355   | .365  | 9.02        | 9.27  |
| BB  | .395     | .405  | 10.03       | 10.29 | S   | .365   | .375  | 9.27        | 9.53  |
| CC  | .170     | .190  | 4.32        | 4.83  | Z   | R.000  | R.040 | R0.00       | R1.02 |
| D   | .455     | .465  | 11.56       | 11.81 |     |        |       |             |       |
| E   | .062     | .066  | 1.57        | 1.68  | aaa |        | .013  |             | 0.33  |
| F   | .004     | .007  | 0.10        | 0.18  | bbb |        | .010  |             | 0.25  |
| H   | .082     | .090  | 2.08        | 2.29  | ccc |        | .020  |             | 0.51  |
| K   | .117     | .137  | 2.97        | 3.48  |     |        |       |             |       |
| L   | .540 BSC |       | 13.72 BSC   |       |     |        |       |             |       |
| M   | 1.219    | 1.241 | 30.96       | 31.52 |     |        |       |             |       |
| N   | 1.218    | 1.242 | 30.94       | 31.55 |     |        |       |             |       |

|  |                    |                            |             |
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| TITLE:<br><br>NI-1230-4S                         |                    | DOCUMENT NO: 98ARB18247C   | REV: H      |
|  |                    | STANDARD: NON-JEDEC        |             |
|  |                    | SOT1829-1                  | 19 FEB 2016 |

**MMRF1312H MMRF1312HS MMRF1312GS**



|   |                          |                            |
|---|--------------------------|----------------------------|
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| TITLE:<br><br>NI-1230-4S GULL                     | DOCUMENT NO: 98ASA00459D | REV: B                     |
|   | STANDARD: NON-JEDEC      |                            |
|   | SOT1806-2                | 23 FEB 2016                |

MMRF1312H MMRF1312HS MMRF1312GS

RF Device Data  
Freescale Semiconductor, Inc.

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

2. CONTROLLING DIMENSION: INCH



3. DIMENSION A1 IS MEASURED WITH REFERENCE TO DATUM T. THE POSITIVE VALUE IMPLIES THAT THE PACKAGE BOTTOM IS HIGHER THAN THE LEAD BOTTOM.

| DIM  | INCHES   |       | MILLIMETERS        |       | DIM                                  | INCHES                     |       | MILLIMETERS |       |  |  |  |  |
|--|----------|-------|--------------------|-------|--------------------------------------|----------------------------|-------|-------------|-------|--|--|--|--|
|  | MIN      | MAX   | MIN                | MAX   |                                      | MIN                        | MAX   | MIN         | MAX   |  |  |  |  |
| AA   | 1.265    | 1.275 | 32.13              | 32.39 | R                                    | .355                       | .365  | 9.02        | 9.27  |  |  |  |  |
| A1   | -.001    | .011  | -0.03              | 0.28  | S                                    | .365                       | .375  | 9.27        | 9.53  |  |  |  |  |
| BB   | .395     | .405  | 10.03              | 10.29 | Z                                    | R.000                      | R.040 | R0.00       | R1.02 |  |  |  |  |
| B1   | .564     | .574  | 14.32              | 14.58 | t'                                   | 0°                         | 8°    | 0°          | 8°    |  |  |  |  |
| CC   | .170     | .190  | 4.32               | 4.83  | aaa                                  |                            | .013  |             | 0.33  |  |  |  |  |
| D  | .455     | .465  | 11.56              | 11.81 | bbb                                  |                            | .010  |             | 0.25  |  |  |  |  |
| E  | .062     | .066  | 1.57               | 1.68  | ccc                                  |                            | .020  |             | 0.51  |  |  |  |  |
| F  | .004     | .007  | 0.10               | 0.18  |                                      |                            |       |             |       |  |  |  |  |
| J  | .540 BSC |       | 13.72 BSC          |       |                                      |                            |       |             |       |  |  |  |  |
| L  | .038     | .046  | 0.97               | 1.17  |                                      |                            |       |             |       |  |  |  |  |
| L1   | .01 BSC  |       | 0.25 BSC           |       |                                      |                            |       |             |       |  |  |  |  |
| M  | 1.219    | 1.241 | 30.96              | 31.52 |                                      |                            |       |             |       |  |  |  |  |
| N  | 1.218    | 1.242 | 30.94              | 31.55 |                                      |                            |       |             |       |  |  |  |  |
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| TITLE:<br>NI-1230-4S GULL                        |          |       |                    |       | DOCUMENT NO: 98ASA00459D      REV: B |                            |       |             |       |  |  |  |  |
|  |          |       |                    |       | STANDARD: NON-JEDEC                  |                            |       |             |       |  |  |  |  |
|  |          |       |                    |       | SOT1806-2      23 FEB 2016           |                            |       |             |       |  |  |  |  |

**MMRF1312H MMRF1312HS MMRF1312GS**

## PRODUCT DOCUMENTATION

Refer to the following resources to aid your design process.

### Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### To Download Resources Specific to a Given Part Number:

1. Go to <http://www.nxp.com/RF>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

## REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date      | Description                     |
|----------|-----------|---------------------------------|
| 0        | Mar. 2016 | • Initial Release of Data Sheet |

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